

P-Channel 200V (D-S) MOSFET

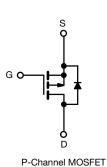
PRODUCT SUMMA	RY	
V _{DS} (V)	-20	0
$R_{DS(on)}(\Omega)$	V _{GS} = -10 V	2.0
Q _g max. (nC)	29	
Q _{gs} (nC)	5.4	
Q _{gd} (nC)	15	
Configuration	Sing	le

FEATURES

- Surface mount
- Available in tape and reel
- Dynamic dV/dt rating
- Repetitive avalanche rated
- P-channel
- Fast switching
- Ease of paralleling







PARAMETER			SYMBOL	LIMIT	UNIT	
Drain-Source Voltage		V _{DS}	-200	V		
Gate-Source Voltage			V_{GS}	± 20] v	
Continuous Drain Current	V at 10 V	I_{GS} at -10 V $I_{C} = 25 ^{\circ}\text{C}$ $I_{C} = 100 ^{\circ}\text{C}$	I _D	-3.0	А	
Continuous Drain Current	VGS at -10 V			-2.0		
Pulsed Drain Current a		I _{DM}	-10			
Linear Derating Factor		0.59 0.025	0.59	W/°C		
Linear Derating Factor (PCB mount) e			0.025			
Single Pulse Avalanche Energy b			E _{AS}	500	mJ	
Avalanche Current ^a			I _{AR}	-6.4	А	
Repetitive Avalanche Energy ^a		E _{AR}	7.4	mJ		
aximum Power Dissipation $T_C = 25 ^{\circ}C$		Б	74	10/		
Maximum Power Dissipation (PCB mount) e	T _A = 25 °C		P_{D}	3.0	W	
Peak Diode Recovery dV/dt ^c		dV/dt	-5.0	V/ns		
Operating Junction and Storage Temperature Range		T _J , T _{stg} -55 to +150		00		
Soldering Recommendations (Peak temperature) d for 10 s			300	°C		

- a. Repetitive rating; pulse width limited by maximum junction temperature (see fig. 11). b. $V_{DD} = -50$ V, starting $T_J = 25$ °C, L = 17 mH, $R_g = 25$ Ω , $I_{AS} = -6.5$ A (see fig. 12). c. $I_{SD} \le -6.5$ A, $dI/dt \le 120$ A/µs, $V_{DD} \le V_{DS}$, $T_J \le 150$ °C. d. 1.6 mm from case. e. When mounted on 1" square PCB (FR-4 or G-10 material).

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THERMAL RESISTANCE RAT	INGS			
PARAMETER	SYMBOL	TYP.	MAX.	UNIT
Maximum Junction-to-Ambient	R _{thJA}	-	62	
Maximum Junction-to-Ambient (PCB mount) ^a	R _{thJA}	-	40	°C/W
Maximum Junction-to-Case (Drain)	R _{thJC}	-	1.7	

Note

a. When mounted on 1" square PCB (FR-4 or G-10 material).

PARAMETER	SYMBOL	TEST CONDITIONS		MIN.	TYP.	MAX.	UNIT
Static							
Drain-Source Breakdown Voltage	V _{DS}	$V_{GS} = 0$, $I_D = -250 \mu A$		-200	-	-	V
V _{DS} Temperature Coefficient	$\Delta V_{DS}/T_{J}$	Referenc	e to 25 °C, I _D = -1 mA	-	-0.24	-	V/°C
Gate-Source Threshold Voltage	V _{GS(th)}	V _{DS} =	· V _{GS} , I _D = -250 μA	-1.5	-	-4.0	V
Gate-Source Leakage	I _{GSS}		$V_{GS} = \pm 20 \text{ V}$	-	-	± 10	μA
Zava Cata Valtaga Dvain Coverent		V _{DS} = -200 V, V _{GS} = 0 V		-	-	- 100	
Zero Gate Voltage Drain Current	I _{DSS}	V _{DS} = -160 \	V, V _{GS} = 0 V, T _J = 125 °C	-	-	-500	μA
Drain-Source On-State Resistance	R _{DS(on)}	V _{GS} = -10 V	I _D = -1.0 A ^b	-	2.00	-	Ω
Forward Transconductance	9 _{fs}	V _{DS} =	-50 V, I _D = -1.0 A ^b	2.8	-	-	S
Dynamic							
Input Capacitance	C _{iss}	$V_{GS} = 0 \text{ V},$ $V_{DS} = -25 \text{ V},$ f = 1.0 MHz, see fig. 5		-	700	-	pF
Output Capacitance	C _{oss}			-	200	-	
Reverse Transfer Capacitance	C_{rss}			-	40	-	
Total Gate Charge	Qg			-	-	29	nC
Gate-Source Charge	Q _{gs}	V _{GS} = -10 V	$I_D = -3.5A$, $V_{DS} = -160 V$, see fig. 6 and 13 b	-	-	5.4	
Gate-Drain Charge	Q_{gd}		see lig. o and to	-	-	15	
Turn-On Delay Time	t _{d(on)}			-	12	-	
Rise Time	t _r	V_{DD} = -100 V, I_{D} = -3.5A, R_{g} = 12 Ω , R_{D} = 15 Ω , see fig. 10 ^b		-	27	-	ns
Turn-Off Delay Time	t _{d(off)}			-	28	-	
Fall Time	t _f		1		24	-	
Internal Drain Inductance	L _D	Between lead, 6 mm (0.25") from		-	4.5	-	- nH
Internal Source Inductance	L _S	package and die contact	package and center of die contact		7.5	-	
Gate Input Resistance	R_g	f = 1 MHz, open drain		0.6	-	3.7	Ω
Drain-Source Body Diode Characteristic	s						
Continuous Source-Drain Diode Current	I _S	MOSFET symbol showing the integral reverse p - n junction diode		-	-	-2	_
Pulsed Diode Forward Current ^a	I _{SM}			-	-	-4	A
Body Diode Voltage	V _{SD}	T _J = 25 °C,	$T_J = 25$ °C, $I_S = -3.5$ A, $V_{GS} = 0$ V b		-	-6.5	V
Body Diode Reverse Recovery Time	t _{rr}	T 05.00 !	0 E A al/at 400 A/ h	-	200	300	ns
Body Diode Reverse Recovery Charge	Q _{rr}	$T_J = 25 ^{\circ}\text{C}$, $I_F = -3.5\text{A}$, $dI/dt = 100 \text{A/µs}^{\text{b}}$		-	1.9	2.9	μC
Forward Turn-On Time	t _{on}	Intrinsic tu	on is dor	ninated b	y L _s and	L _D)	

Notes

- a. Repetitive rating; pulse width limited by maximum junction temperature (see fig. 11).
- b. Pulse width $\leq 300~\mu s;$ duty cycle $\leq 2~\%.$



TYPICAL CHARACTERISTICS (25 °C, unless otherwise noted)

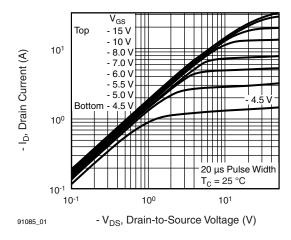


Fig. 1 - Typical Output Characteristics, T_C = 25 °C

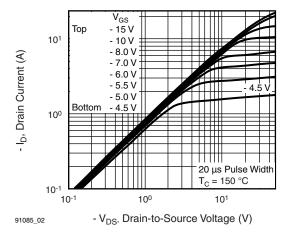


Fig. 2 - Typical Output Characteristics, $T_C = 150 \, ^{\circ}\text{C}$

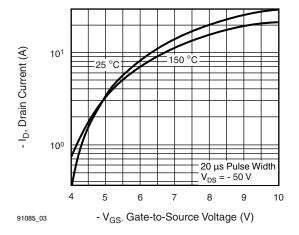


Fig. 3 - Typical Transfer Characteristics

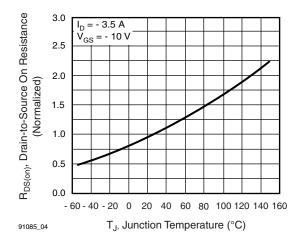


Fig. 4 - Normalized On-Resistance vs. Temperature

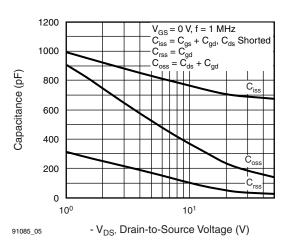


Fig. 5 - Typical Capacitance vs. Drain-to-Source Voltage

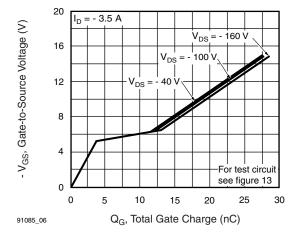


Fig. 6 - Typical Gate Charge vs. Gate-to-Source Voltage



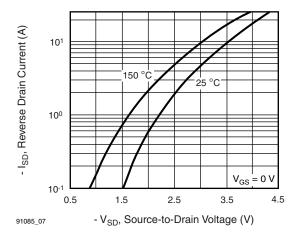


Fig. 7 - Typical Source-Drain Diode Forward Voltage

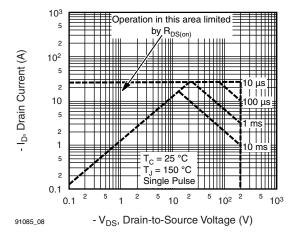


Fig. 8 - Maximum Safe Operating Area

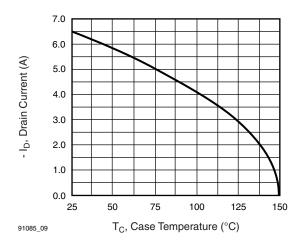


Fig. 9 - Maximum Drain Current vs. Case Temperature

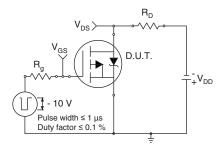


Fig. 10a - Switching Time Test Circuit

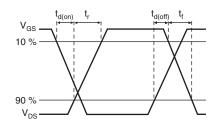


Fig. 10b - Switching Time Waveforms

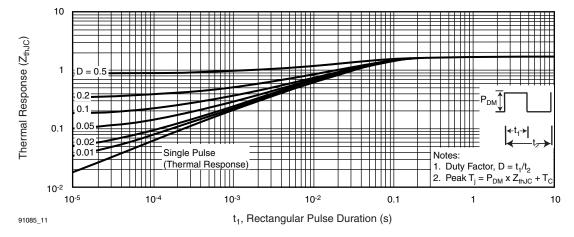


Fig. 11 - Maximum Effective Transient Thermal Impedance, Junction-to-Case



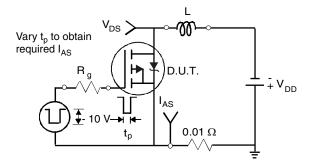


Fig. 12a - Unclamped Inductive Test Circuit

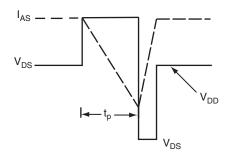


Fig. 12b - Unclamped Inductive Waveforms

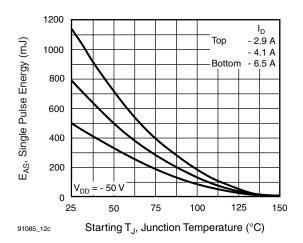


Fig. 12c - Maximum Avalanche Energy vs. Drain Current

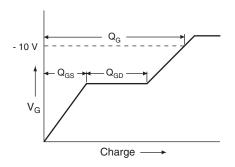


Fig. 13a - Basic Gate Charge Waveform

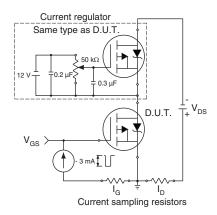
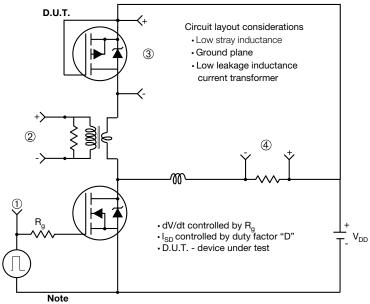


Fig. 13b - Gate Charge Test Circuit



Peak Diode Recovery dV/dt Test Circuit



• Compliment N-Channel of D.U.T. for driver

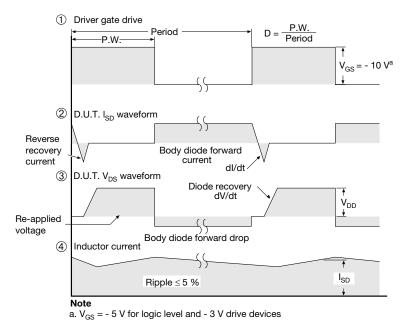
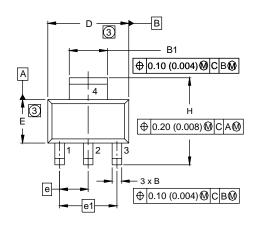
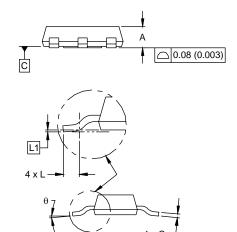


Fig. 14 - For P-Channel



SOT-223 (HIGH VOLTAGE)





	MILLIMETERS		INCHES		
DIM.	MIN.	MAX.	MIN.	MAX.	
Α	1.55	1.80	0.061	0.071	
В	0.65	0.85	0.026	0.033	
B1	2.95	3.15	0.116	0.124	
С	0.25	0.35	0.010	0.014	
D	6.30	6.70	0.248	0.264	
Е	3.30	3.70	0.130	0.146	
е	2.30	2.30 BSC		0.0905 BSC	
e1	4.60	4.60 BSC		BSC	
Н	6.71	7.29	0.264	0.287	
L	0.91	-	0.036	-	
L1	0.061 BSC		0.0024	4 BSC	
θ	-	10'	-	10'	

ECN: S-82109-Rev. A, 15-Sep-08

DWG: 5969

Notes

- 1. Dimensioning and tolerancing per ASME Y14.5M-1994.
- 2. Dimensions are shown in millimeters (inches).
- 3. Dimension do not include mold flash.
- 4. Outline conforms to JEDEC outline TO-261AA.

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